FORM 1449* INFORMATION DISCLOSURE STATEMENT					Docket Number: Application Numb STFD.021C1 10/042,426					
IN AN APPLICATION  Applicant: Dai et al.										
(Use several sheets if necessary)									Group Art Unit: 1741	
MAY 2 3 2002										
U.S. PATENT DOCUMENTS  EXAMINER DOCUMENT NO. DATE NAME CLASS SUBCLASS FILING DATE										
EXAMINER INITIAL	DOCUN	MENT NO.	DATE	NAME		CLASS	SUBC	LASS		G DATE ROPRIATE
WA	6,346,189		2/12/2002	Dai et al.						
	5,482,601		1/09/1996	Ohshima et al.			_			
	5,500,200		3/19/1996	Mandeville et al.		-	_			
	5,780,101	-	7/14/1998	Nolan et al.						
	5,547,748		8/20/1996	Ruoff et al.			_			
	5,643,670		7/01/1997	Chung			חה			
	5,650,370		7/22/1997	Tennant et al.			HE	JEI	VFD	
	5,690,997		11/25/1997	Grow			MAY	9 1 6		
	5,707,916		1/13/1998	Snyder et al.				257	002	
w/L	5,726,116		3/10/1998	Moy et al.			TG	170	)()	
								-, (	-	
	<u> </u>									
			FF	OREIGN PATENT DOC	UMENTS					
	DOCUMENT NO		DATE	COUNTRY		CLASS	SUBCL	.ASS	TRANS	LATION
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WK.	913 508 A2		2/1998	Europe				_	Х	
<u> </u>	9510481		4/1995	World/PCT			_	-	Х	
w~.	9805920		2/1998	World/PCT			_	-	Х	
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)										
WN	Dai, H., "Nanotubes as nanoprobes in scanning probe microscopy," Nature, vol. 384, Nov. 14, 1996, p				1996, pp. 147-	149.				
								-		

EXAMINER	$\mathcal{C}_{\mathcal{S}}$	Mar	DATE CONSIDERED	5/20/03	
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form for next communication to the Applicant.

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FCRM 1449*	INFORMATION DISCLOSURE STATEMEN	AL A	20,03	Docket Number: STFD.021C1	Application Number: 10/042,426
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EXAMINER	DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS	FILIN	G DATE
INITIAL							POPRIATE
wn	5,488,906	9/12/1995	Cheung				
	4,495,793	1/29/1985	Hager		)		
	5,436,167	7/25/1995	Robillard		_		
	5,866,434	2/2/1999	Massey et al.			3	
	6,162,926	12/19/ 2000	Murphy et al.			AUG TECHNOLOG	72
	5,653,951	8/05/1997	Rodriguez et al.		_	8 8	C
W_	5,626,650	5/06/1997	Rodriguez et al.		_	35	
						2002 NTER	m
						R 17	0
						1700	
		FC	REIGN PATENT DOCUME	NTS			
	DOCUMENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	TRANS	LATION
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	отн	ER DOCUMENTS	(Including Author, Title, Dat	e, Pertinent Pages	, Etc.)	·	
w~_	/9, No. 14,	pages 2258-2260					
w^_	KOSHIO, A J. Phys. CI	A. et al, "In situ las nem. B, July 2000,	er-furnace TOF mass spectr Vol. 104, pages 7908-7913.	ometry of C36 and especially pages	the large-scale pr 7908-7909.	oduction by arc	-discharge

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